

COMPOUND TRANSISTOR

on-chip resistor NPN silicon epitaxial transistor For mid-speed switching

 \mathcal{M}_{R_1}

QС

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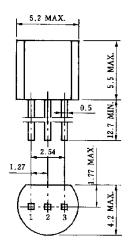
FEATURES

- On-chip bias resistor (R1 = 47 kΩ)
- Complementary transistor with AN1L4Z

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Symbol	Ratings	Unit
Vсво	60	V
VCEO	50	V
VEBO	5	V
IC(DC)	100	mA
IC(pulse) *	200	mA
Р⊤	250	mW
Tj	150	°C
Tstg	–55 to +150	°C
	VCBO VCEO VEBO IC(DC) IC(pulse) * PT Tj	V 0 V 60 V 50 V 50 V 50 Ic(po) 100 Ic(pulse) * 200 PT 250 Tj 150

ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

PACKAGE DRAWING (UNIT: mm)



Electrode Connection

1. Emitter EIAJ SC-43B

2. Collector JEDEC : TO-92

3. Base IEC PA33

* PW \leq 10 ms, duty cycle \leq 50 %

ELECTRICAL CHARACTERISTICS (Ta = 25°C)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector cutoff current	Ісво	$V_{CB} = 50 \text{ V}, \text{ I}_{E} = 0$			100	nA
DC current gain	hfe1 **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 5.0 \text{ mA}$	135	270	600	-
DC current gain	hfe2 **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 50 \text{ mA}$	100	260		-
Collector saturation voltage	VCE(sat) **	Ic = 5.0 mA, I _B = 0.25 mA		0.05	0.2	V
Low level input voltage	VIL **	$V_{CE} = 5.0 \text{ V}, \text{ Ic} = 100 \ \mu\text{A}$		0.57	0.5	V
High level input voltage	VIH **	$V_{CE} = 0.2 V$, $I_{C} = 5.0 mA$	4.0	1.7		V
Input resistance	R1		32.9	47	61.1	kΩ
Turn-on time	ton	$V_{CC} = 5.0 \text{ V}, \text{ R}_{L} = 1.0 \text{ k}\Omega$			0.2	μs
Storage time	tstg	$V_{I} = 5.0 V, PW = 2.0 \mu s$			5.0	μs
Turn-off time	toff	duty cycle≤2 %			6.0	μs

** Pulse test PW \leq 350 μ s, duty cycle \leq 2 %

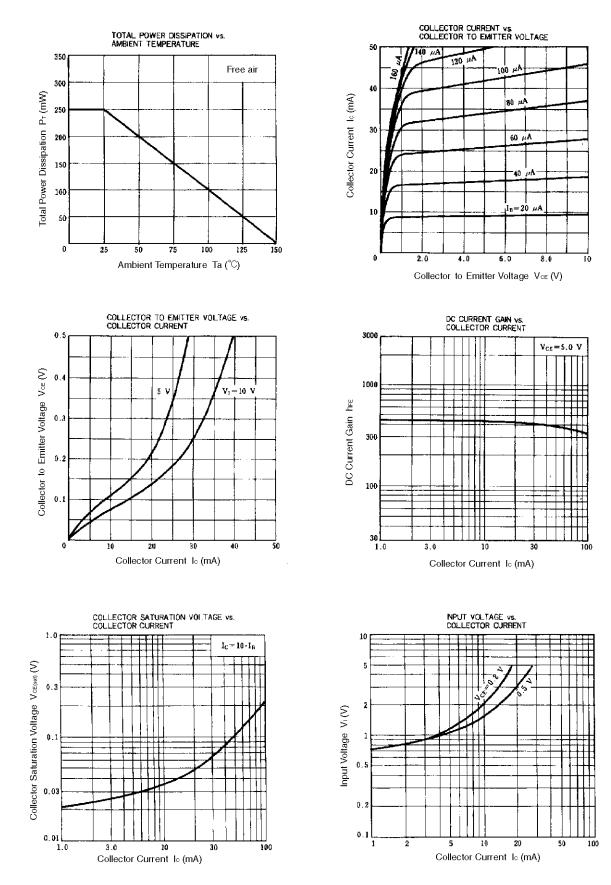
hfe CLASSIFICATION

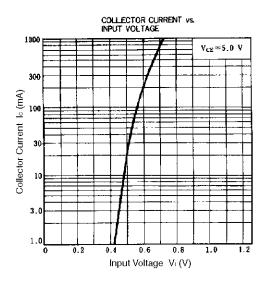
Marking	Q	Р	К
hfe1	135 to 270	200 to 400	300 to 600

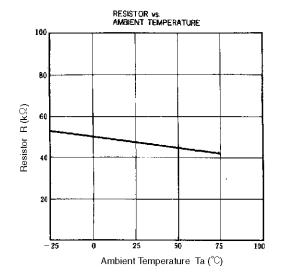
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TYPICAL CHARACTERISTICS (Ta = 25°C)







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